



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. .... 10/609,311  
Filing Date ..... June 26, 2003  
Inventor ..... Donald L. Yates  
Assignee ..... Micron Technology, Inc.  
Group Art Unit ..... 1756  
Examiner ..... Nicole M. Barreca  
Attorney's Docket No. .... MI22-2236  
Customer No. .... 021567  
Title ..... Semiconductor Processing Patterning Methods

**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT**

Reference - - See attached Form PTO-1449

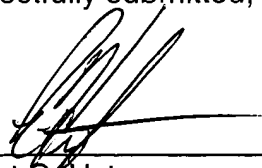
The attached Form PTO-1449 is submitted in compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98. Pursuant to Federal Register Vol. 69, No. 182, pg. 56542 (September 21, 2004), no copies of any cited U.S. patents or U.S. published applications are included herewith. No admission is made regarding whether the submitted reference is prior art.

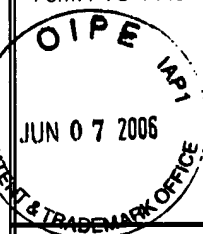
This Supplemental Information Disclosure Statement is being filed with a Response to Final Office Action to Accompany Request for Continued Examination (RCE). Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925

Citation of these references is respectfully requested.

Respectfully submitted,

Date: 6/7/06

  
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Robert C. Hyta  
Reg. No. 46,791

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2236		SERIAL NO. 10/609,311	
 <p>LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)</p>				APPLICANT: Donald L. Yates			
				FILING DATE June 26, 2003		GROUP 1756	
<b>U.S. PATENT DOCUMENTS</b>							
*Examiner's Initials	AA	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	5,994,194	11/99	Lammert			
	AB	6,582,861	06/03	Buxbaum, et al.			
	AC	6,838,363	01/05	Wieczorek, et al.			
	AD	6,956,980	10/05	Nagata, et al.			
	AE	2005/0244571	11/05	Walheim, et al.			
	AF	10/822,118	04/04	Sandhu, et al.			
	AG						
	AH						
	AI						
	AJ						
<b>FOREIGN PATENT DOCUMENTS</b>							
		Document Number	Date	Country	Class	Subclass	Translation
							Yes      No
	AJ						
	AK						
	AL						
<b>OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)</b>							
	AM						
	AN						
	AO						
EXAMINER		DATE CONSIDERED					
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>							